


<b>Search Notes</b>  	<b>Application/Control No.</b>  10565394	<b>Applicant(s)/Patent Under Reexamination</b>  KOBAYASHI ET AL.
	<b>Examiner</b>  Hau V Phan	<b>Art Unit</b>  3618

SEARCHED			
Class	Subclass	Date	Examiner
180	89.2, 309, 296, 219	11/18/08	HP
181	250, 207, 273, 227	11/18/08	HP
60	322, 299	11/18/08	HP

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Hau V Phan/ Primary Examiner.Art Unit 3618
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